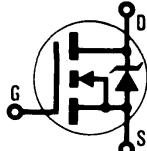


INTERNATIONAL RECTIFIER



## REPETITIVE AVALANCHE RATED AND dv/dt RATED

## HEXFET® TRANSISTOR



N-CHANNEL

IRFM150

2N7224

JANTX2N7224

JANTXV2N7224

[REF: MIL-S-19500/592]

## 100 Volt, 0.07 Ohm HEXFET

The HEXFET® technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies and virtually any application where military and/or high reliability is required.

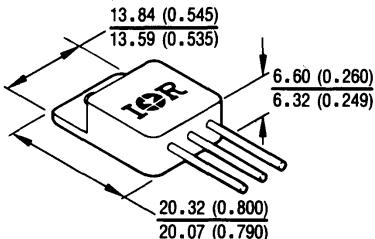
## Product Summary

Part Number	BVDSS	R <sub>DSON</sub>	I <sub>D</sub>
IRFM150	100V	0.07Ω	34A

## FEATURES:

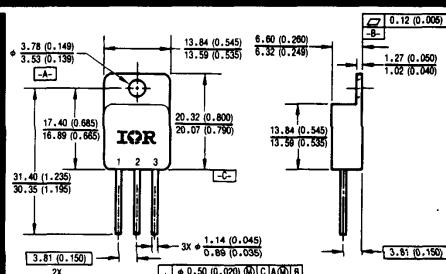
- Repetitive Avalanche Rating
- Isolated and Hermetically Sealed
- Alternative to TO-3 Package
- Simple Drive Requirements
- Ease of Paralleling
- Ceramic Eyelets

## CASE STYLE AND DIMENSIONS



CAUTION

BERYLIA WARNING PER MIL-S-19500  
SEE PAGE I-308



LEGEND  
1 DRAIN  
2 SOURCE  
3 GATE

NOTES:  
1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M - 1982.  
2 ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).

Conforms to JEDEC Outline TO-254AA\*  
Dimensions in Millimeters and (Inches)

\*For leadform configurations see page I-308, fig. 15

# Absolute Maximum Ratings

Parameter	IRFM150, JANTXV, JANTX, 2N7224	Units
$I_D @ V_{GS} = 10V, T_C = 25^\circ C$ Continuous Drain Current	34	
$I_D @ V_{GS} = 10V, T_C = 100^\circ C$ Continuous Drain Current	21	A
$I_{DM}$ Pulsed Drain Current ①	136	
$P_D @ T_C = 25^\circ C$ Max. Power Dissipation	150	W
Linear Derating Factor	1.2	W/K ⑤
$V_{GS}$ Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$ Single Pulse Avalanche Energy ②	150 (See Fig. 12)	mJ
$I_{AR}$ Avalanche Current ①	34 (See $E_{AR}$ )	A
$E_{AR}$ Repetitive Avalanche Energy ①	15 (See Fig. 13)	mJ
$dV/dt$ Peak Diode Recovery $dV/dt$ ③	5.5 (See Fig. 13)	V/ns
$T_J$ $T_{STG}$ Operating Junction Storage Temperature Range	-55 to 150	°C
Lead Temperature	300 (0.063 in. (1.6 mm) from case for 10s)	
Weight	9.3 (typical)	g

## Electrical Characteristics @ $T_J = 25^\circ C$ (Unless Otherwise Specified)

Parameter	Min.	Typ.	Max.	Units	Test Conditions		
$V_{DSS}$ Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS} = 0V, I_D = 1.0\text{ mA}$		
$\Delta V_{DSS}/\Delta T_J$ Temperature Coefficient of Breakdown Voltage	—	0.13	—	V/°C	Reference to $25^\circ C, I_D = 1.0\text{ mA}$		
$R_{DS(on)}$ Static Drain-to-Source On-State Resistance	—	—	0.07	$\Omega$	$V_{GS} = 10V, I_D = 21A$	④	
	—	—	0.081		$V_{GS} = 10V, I_D = 34A$		
$V_{GS(th)}$ Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu A$		
$g_f$ Forward Transconductance	9.0	—	—	S (0)	$V_{DS} \geq 15V, I_{DS} = 21A$ ④		
$I_{DSS}$ Zero Gate Voltage Drain Current	—	—	25	$\mu A$	$V_{DS} = 0.8 \times \text{Max. Rating}, V_{GS} = 0V$		
	—	—	250		$V_{DS} = 0.8 \times \text{Max. Rating}$		
	—	—	—		$V_{GS} = 0V, T_J = 125^\circ C$		
$I_{GSS}$ Gate-to-Source Leakage Forward	—	—	100	nA	$V_{GS} = 20V$		
$I_{GSS}$ Gate-to-Source Leakage Reverse	—	—	-100	nA	$V_{GS} = -20V$		
$Q_g$ Total Gate Charge	50	—	125	nC	$V_{GS} = 10V, I_D = 34A$		
$Q_{gs}$ Gate-to-Source Charge	8	—	22		$V_{DS} = 0.5 \times \text{Max. Rating}$		
$Q_{gd}$ Gate-to-Drain ("Miller") Charge	15	—	65		See Fig. 6 and 14		
$t_d(on)$ Turn-On Delay Time	—	—	35	ns	$V_{DD} = 50V, I_D = 34A, R_G = 2.35\Omega$		
$t_r$ Rise Time	—	—	190		See Fig. 11		
$t_d(off)$ Turn-Off Delay Time	—	—	170				
$t_f$ Fall Time	—	—	130				
$L_D$ Internal Drain Inductance	—	8.7	—	nH	Measured from the drain lead, 6 mm (0.25 in.) from package to center of die.	Modified MOSFET symbol showing the internal inductances. 	
$L_S$ Internal Source Inductance	—	8.7	—		Measured from the source lead, 6 mm (0.25 in.) from package to source bonding pad.		
$C_{iss}$ Input Capacitance	—	3700	—		$V_{GS} = 0V, V_{DS} = 25V$		
$C_{oss}$ Output Capacitance	—	1100	—	pF	$f = 1.0\text{ MHz}$		
$C_{rss}$ Reverse Transfer Capacitance	—	200	—		See Fig. 5		
$C_{DC}$ Drain-to-Case Capacitance	—	12	—				



## IRFM150, JANTXV, JANTX-, 2N7224 Devices

### Source-Drain Diode Ratings and Characteristics

Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_S$ Continuous Source Current (Body Diode)	—	—	34		Modified MOSFET symbol showing the integral Reverse p-n junction rectifier.
$I_{SM}$ Pulsed Source Current (Body Diode) ①	—	—	136	A	
$V_{SD}$ Diode Forward Voltage	—	—	1.8	V	$T_J = 25^\circ\text{C}$ , $I_S = 34\text{A}$ , $V_{GS} = 0\text{V}$ ④
$t_{rr}$ Reverse Recovery Time	—	—	500	nS	$T_J = 25^\circ\text{C}$ , $I_F = 34\text{A}$ , $dI/dt \leq 100 \text{ A}/\mu\text{s}$ ④
$Q_{RR}$ Reverse Recovery Charge	—	—	2.9	$\mu\text{C}$	$V_{DD} \leq 50\text{V}$
$t_{on}$ Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$ .				



### Thermal Resistance

Parameter	Min.	Typ.	Max.	Units	Test Conditions
$R_{thJC}$ Junction-to-Case	—	—	0.83		
$R_{thCS}$ Case-to-Sink	—	0.21	—	K/W ⑤	Mounting surface flat, smooth, and greased
$R_{thJA}$ Junction-to-Ambient	—	—	48		Typical socket mount

① Repetitive Rating; Pulse width limited by maximum junction temperature (see figure 9)  
Refer to current HEXFET reliability report

② @  $V_{DD} = 25\text{V}$ , Starting  $T_J = 25^\circ\text{C}$ ,  
 $L \geq 200 \mu\text{H}$ ,  $R_G = 250\Omega$ ,  
Peak  $I_L = 34\text{A}$

③  $I_{SD} \leq 34\text{A}$ ,  $dI/dt \leq 70 \text{ A}/\mu\text{s}$ ,  
 $V_{DD} \leq BV_{DSS}$ ,  $T_J \leq 150^\circ\text{C}$   
Suggested  $R_G = 2.35 \Omega$

④ Pulse width  $\leq 300 \mu\text{s}$ ; Duty Cycle  $\leq 2\%$

⑤ K/W =  $^\circ\text{C}/\text{W}$   
W/K =  $\text{W}/^\circ\text{C}$

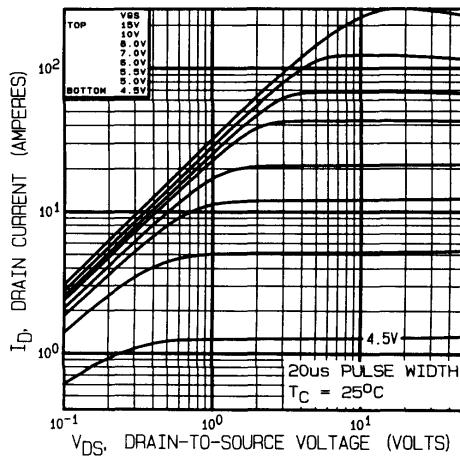
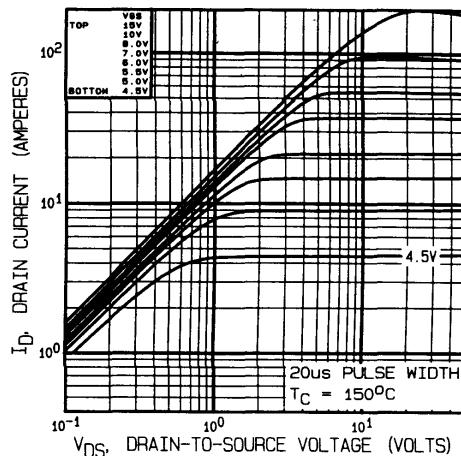
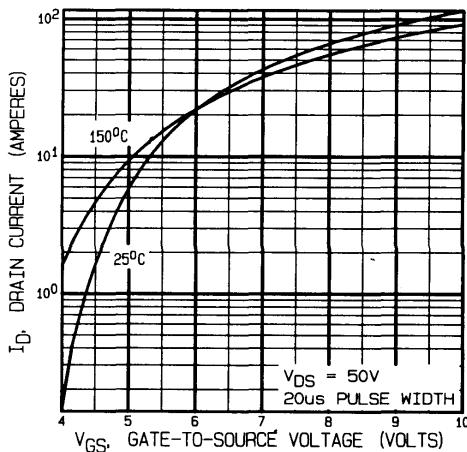
Fig. 1 — Typical Output Characteristics,  $T_C = 25^\circ\text{C}$ Fig. 2 — Typical Output Characteristics,  $T_C = 150^\circ\text{C}$ 

Fig. 3 — Typical Transfer Characteristics

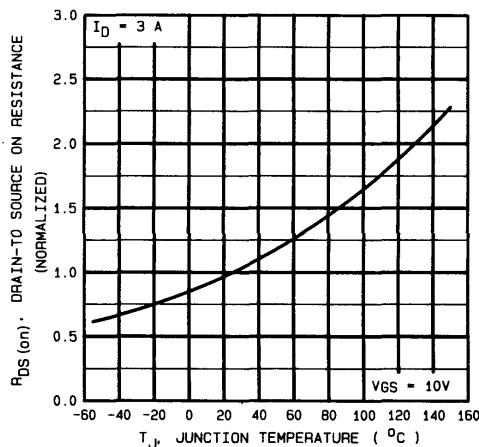


Fig. 4 — Normalized On-Resistance Vs. Temperature

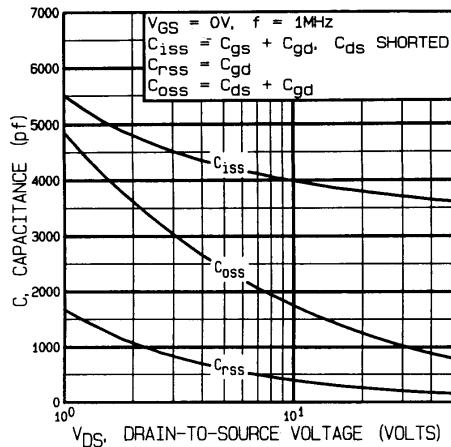


Fig. 5 — Typical Capacitance Vs. Drain-to-Source Voltage

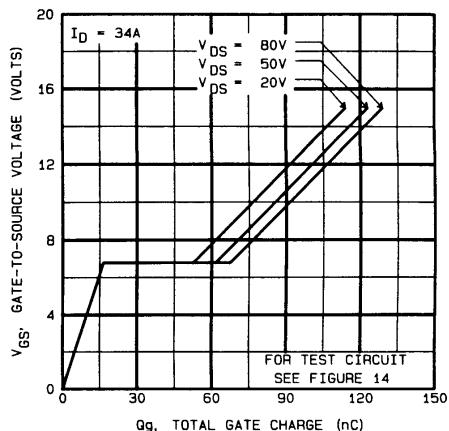


Fig. 6 — Typical Gate Charge Vs. Gate-to-Source Voltage

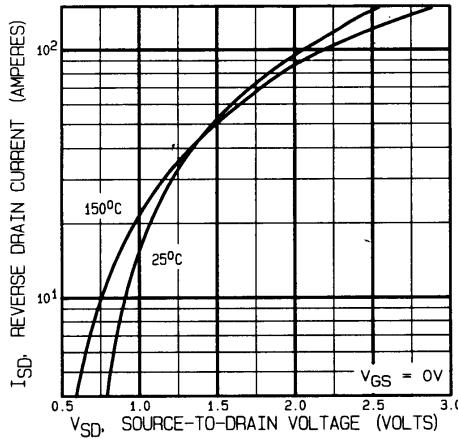


Fig. 7 — Typical Source-Drain Diode Forward Voltage

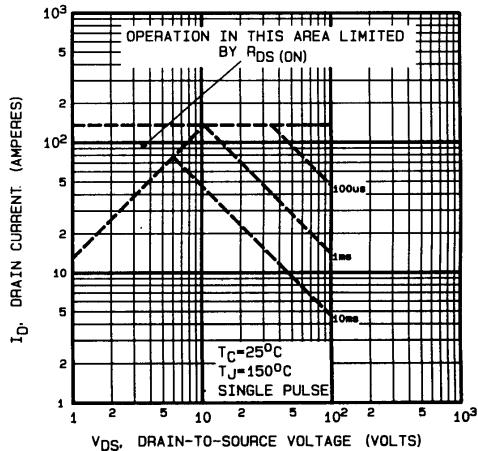


Fig. 8 — Maximum Safe Operating Area

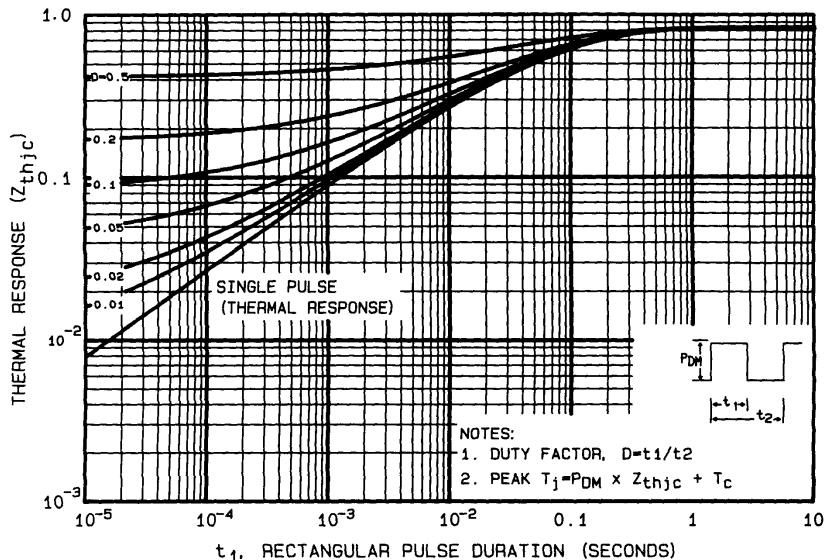


Fig. 9 — Maximum Effective Transient Thermal Impedance, Junction-to-Case Vs. Pulse Duration

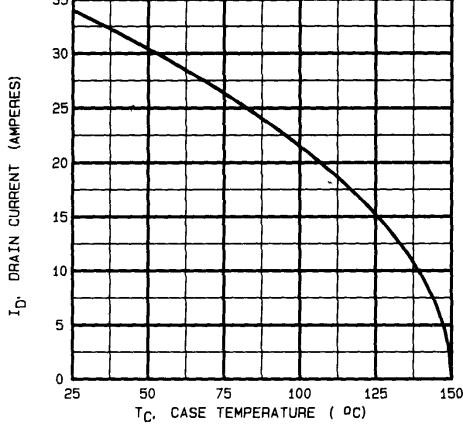


Fig. 10 — Maximum Drain Current Vs. Case Temperature

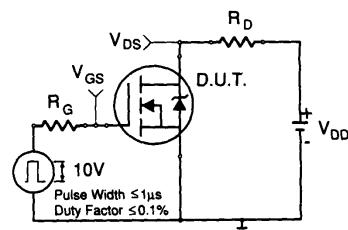


Fig. 11a — Switching Time Test Circuit

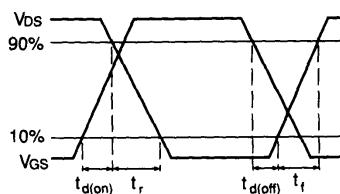


Fig. 11b — Switching Time Waveforms

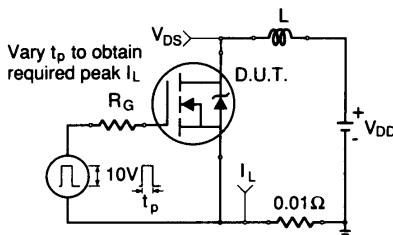


Fig. 12a — Unclamped Inductive Test Circuit

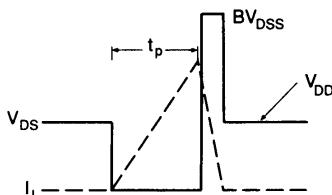


Fig. 12b — Unclamped Inductive Waveforms

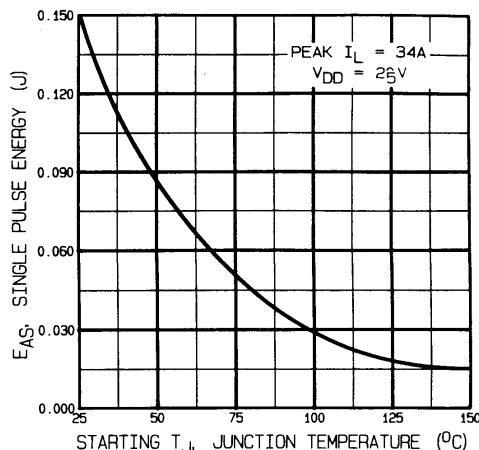
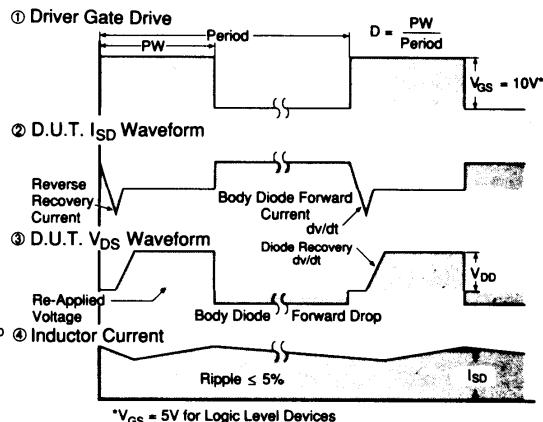
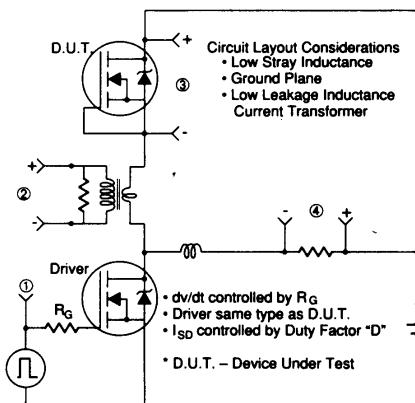
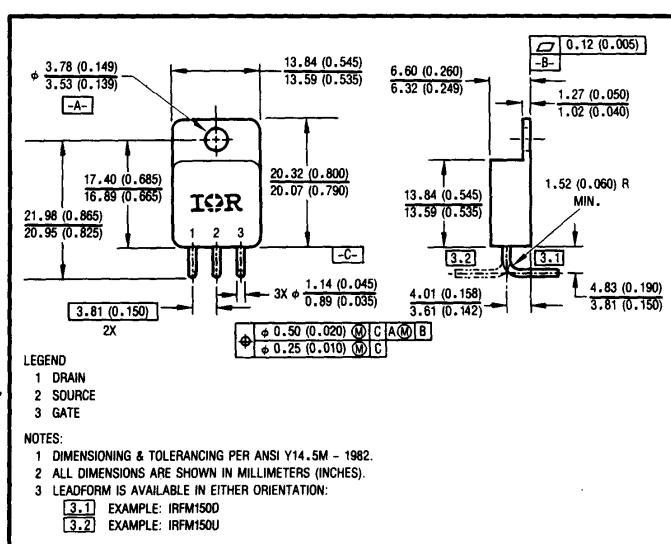
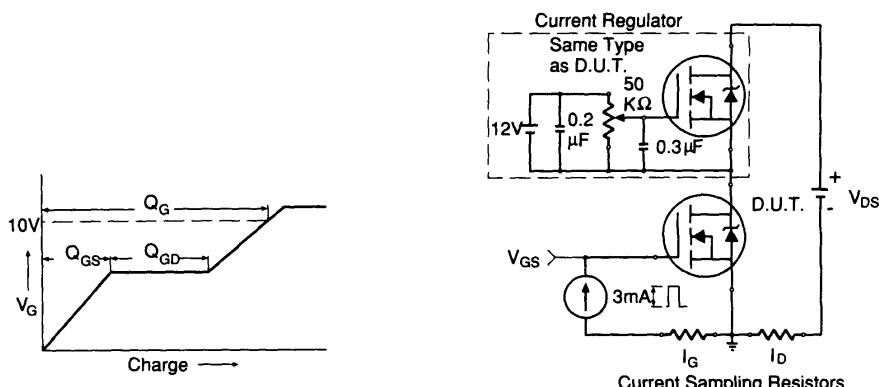


Fig. 12c — Maximum Avalanche Energy Vs. Starting Junction Temperature

Fig. 13 — Peak Diode Recovery  $dv/dt$  Test Circuit



**Fig. 15 — Optional Leadforms for Outline TO-254**

**BERYLIA WARNING PER MIL-S-19500**  
 Packages containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.

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